

<b>Notice of References Cited</b>	Application/Control No. 10/548,318	Applicant(s)/Patent Under Reexamination OHKAWA, SHINGO	
	Examiner ANABEL M. TON	Art Unit 2875	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0232137	09-2008	Fukuda et al.	362/620
	B	US-			
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